## TABLE I. DEVICE PARAMETERS 1/

JPL PART # ST12149-	MFG.	MFG PART#	PACKAGE Style	DETAIL S CREENING TESTS	ELECTRICAL Characteristics & Group a tests	RADIATION (TID) LEVEL RAD(Si)
QN4856TR QN485 <i>T</i> TR QN4858TR	SIX/MOT	2N4856 2N4857 2N4858	TO-18 <u>2</u> /	MIL-S- 19500/385	MIL-S-19500/385 (Table I)	100k <u>3</u> /

## **NOTES**:

- 1/ This drawing, in conjunction with CS515581, imposes all requirements for procurement of these devices.
- 2/ Device physical dimensions shall conform to MIL-S-19500/385, Figure 1.
- 3/ Sufficient radiation tolerance to this TID level is quaranteed by design for this device. (See CS515581, Paragraph 4.7.7).
- 4. This standard takes precedence over documents referenced herein.

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REVISION: C	APPROVED BY:	DATE:						
		APPROVED SOURCE(S)		THE ITEM LISTED IN THE APPROVED SOURCE BLOCK AND IDENTIFIED BY VENDOR NAME ADDRESS. AND PART NUMBER WILL BE EVALUATED AND TESTED BY THE IPLEIGETRONIC PARTS RELIABILITY SECTION OR ITS DELICATED ALTER MATE BEFORE BEING APPROVED FOR USE MON-IPLUSERS SHALL CHECK WITH THE ELECTRONIC PARTS RELIABILITY SECTION ON THE STATUS OF THE PARTS APPROVAL BEFORE BEING				
VENDOR PART NO	)	VENDOR	JPL PART NO					
	JET PROPULSION I		F TECHNOLOGY	CAGENO 23835				
Procurement specification: CS515581 Screening specification: ZPP-2073-GEN	1	TRANSISTOR, SILICON, JFET N-CHANNEL		DETAIL Specification				
				ST 12149				
Custodian: Electronic Parts Reliability Section 514				SHEET 1 OF 1				

Filename: ST12149.C

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